

Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10705591	LEE ET AL.
	Examiner Han, Jason M	Art Unit 2875

Class	SubClass	Date	Examiner
362	600, 606, 623-629	5/25/2006	JMH
349	56, 61-62, 65, 70	5/25/0062	JMH

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EAST - (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	05/25/2006	JMH
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